

N-Channel 500-V (D-S) Super Junction MOSFET

PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	500				
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V 0. 240				
Q _g max. (nC)	66				
Q _{gs} (nC)	8				
Q _{gd} (nC)	14				
Configuration	Single				

FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Low gate charge (Q_q)
- Avalanche energy rated (UIS)

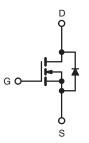
RoHS COMPLIANT HALOGEN FREE

APPLICATIONS

- Computing
 - PC silver box / ATX power supplies



Top View



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Current (T _{.I} = 150 °C)	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	I _D	14	А	
Continuous Drain Current (1) = 130 C)		T _C = 100 °C		9. 0		
Pulsed Drain Current ^a			I _{DM}	28		
Linear Derating Factor				1.25	W/°C	
Single Pulse Avalanche Energy b			E _{AS}	136	mJ	
Maximum Power Dissipation			P _D	156	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope $V_{DS} = 0 \text{ V to } 80 \text{ % } V_{DS}$		dV/dt	70	V/ns		
Reverse Diode dV/dt ^d			27	V/IIS		
Soldering Recommendations (Peak Temperature) c for 10 s				300	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 3.1 A.
- c. 1.6 mm from case.
- d. $I_{SD} \leq I_{D}, \, dI/dt = 100$ A/µs, starting $T_{J} = 25$ °C.

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	0.8	C/VV	



PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•	_	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	500	-	-	٧
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.62	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Cata Carriaga Lagliaga	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Gate-Source Leakage			$V_{GS} = \pm 30 \text{ V}$	-	-	± 1	μA
Zava Cata Valtaga Dvain Cuwant		V _{DS} =	= 500 V, V _{GS} = 0 V	-	-	10	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	['] , V _{GS} = 0 V, T _J = 125 °C	-	-	25	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 7.5 A	-		0. 240	Ω
Forward Transconductance	9 _{fs}	V_{DS}	= 30 V, I _D = 7.5 A	-	3.9	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	1162	-	
Output Capacitance	C _{oss}		$V_{DS} = 100 \text{ V},$	-	51	-	
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		-	7	-	pF
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	$V_{DS} = 0 \text{ V to } 400 \text{ V}, V_{GS} = 0 \text{ V}$		-	55	-	
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	164	-	
Total Gate Charge	Qg	V _{GS} = 10 V I _D = 7.5 A, V _{DS} = 400 V		-		66	nC
Gate-Source Charge	Q _{gs}			-	-	8	
Gate-Drain Charge	Q_{gd}			-	-	14	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 400 V, I _D = 12 A,		-	15	30	
Rise Time	t _r			-	24	48	
Turn-Off Delay Time	t _{d(off)}		= 10 V, $R_q = 9.1 \Omega$	-	34	68	- ns
Fall Time	t _f		Ç	-	18	36	
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	0.85	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	14.5	
Pulsed Diode Forward Current	I _{SM}			-	-	28	A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 7.5 A, V _{GS} = 0 V		_	-	1.2	V
Reverse Recovery Time	t _{rr}		., 25 0, 15 - 1.5 1, 165 - 0 1		265	-	ns
Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 7.5 \text{ A},$ $dI/dt = 100 \text{ A/}\mu\text{s}, V_R = 25 \text{ V}$		-	3.2	-	μC
Reverse Recovery Current	I _{RRM}			-	23	<u> </u>	Α

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

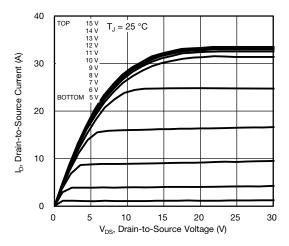


Fig. 1 - Typical Output Characteristics

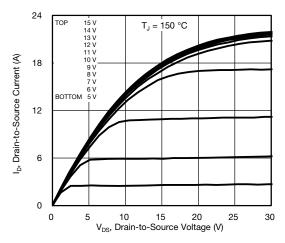


Fig. 2 - Typical Output Characteristics

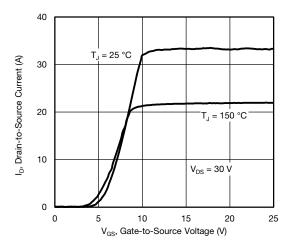


Fig. 3 - Typical Transfer Characteristics

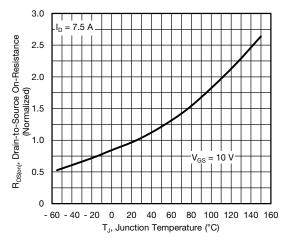


Fig. 4 - Normalized On-Resistance vs. Temperature

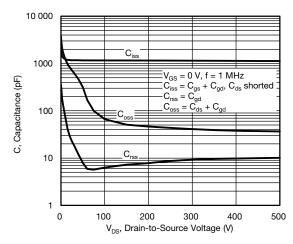


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

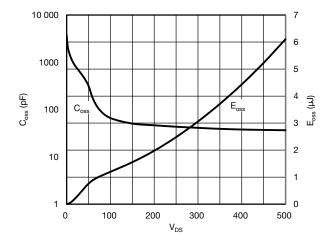


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}



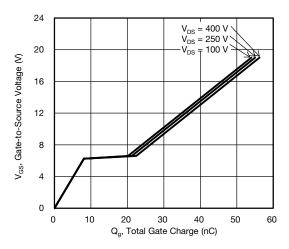


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

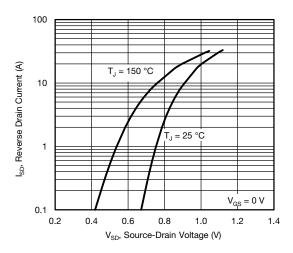


Fig. 8 - Typical Source-Drain Diode Forward Voltage

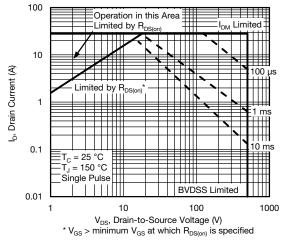


Fig. 9 - Maximum Safe Operating Area

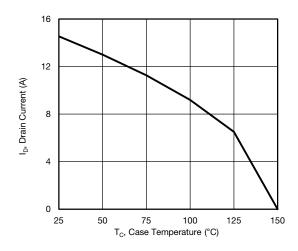


Fig. 10 - Maximum Drain Current vs. Case Temperature

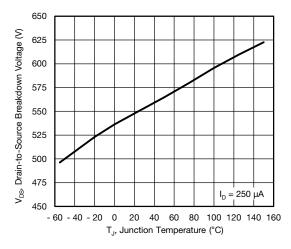


Fig. 11 - Temperature vs. Drain-to-Source Voltage



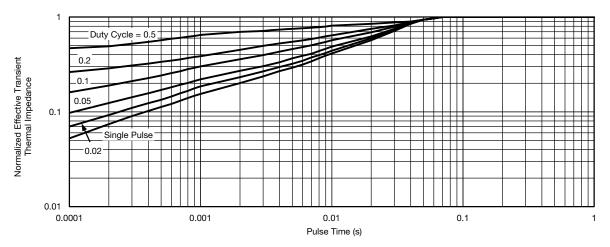


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

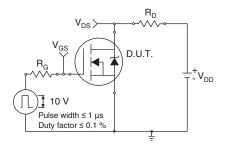


Fig. 13 - Switching Time Test Circuit

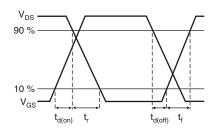


Fig. 14 - Switching Time Waveforms

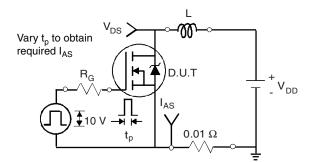


Fig. 15 - Unclamped Inductive Test Circuit

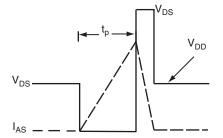


Fig. 16 - Unclamped Inductive Waveforms

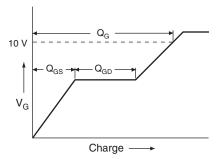


Fig. 17 - Basic Gate Charge Waveform

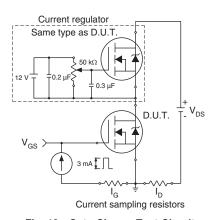
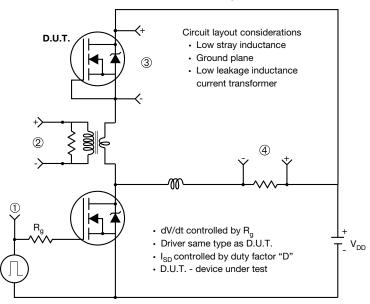


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



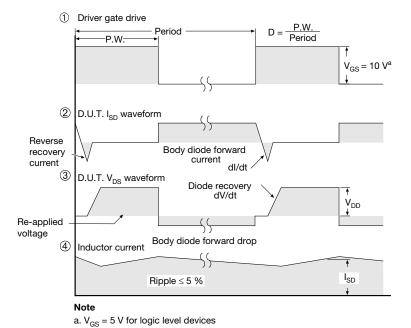
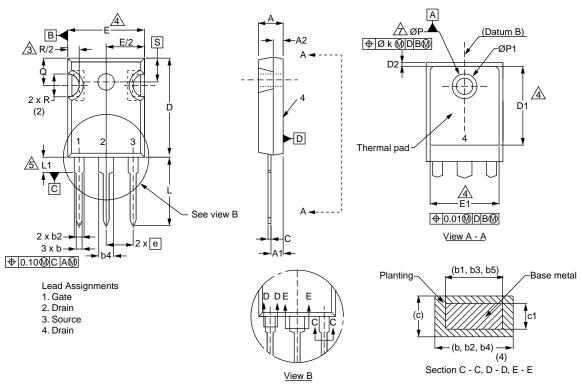


Fig. 19 - For N-Channel



TO-247AC (High Voltage)



	MILLIMETERS		MILLIMETERS INCHE		HES
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.58	5.31	0.180	0.209	
A1	2.21	2.59	0.087	0.102	
A2	1.17	2.49	0.046	0.098	
b	0.99	1.40	0.039	0.055	
b1	0.99	1.35	0.039	0.053	
b2	1.53	2.39	0.060	0.094	
b3	1.65	2.37	0.065	0.093	
b4	2.42	3.43	0.095	0.135	
b5	2.59	3.38	0.102	0.133	
С	0.38	0.86	0.015	0.034	
c1	0.38	0.76	0.015	0.030	
D	19.71	20.82	0.776	0.820	
D1	13.08	-	0.515	-	

	MILLIM	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D2	0.51	1.30	0.020	0.051	
E	15.29	15.87	0.602	0.625	
E1	13.72	-	0.540	-	
е	5.46 BSC 0.215 BS		BSC		
Øk	0.2	0.254		0.010	
L	14.20	16.25	0.559	0.640	
L1	3.71	4.29	0.146	0.169	
N	7.62 BSC		0.300 BSC		
ØΡ	3.51	3.66	0.138	0.144	
Ø P1	-	7.39	-	0.291	
Q	5.31	5.69	0.209	0.224	
R	4.52	5.49	0.178	0.216	
S	5.51 BSC		0.217	BSC	



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